CA3000/...

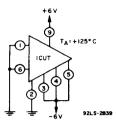
High-Reliability DC Amplifier

The CA3000 Slash (/) Series type is supplied in the 10-lead TO-5 style package.

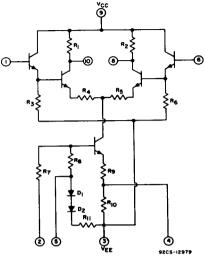
| Characteristics | | Test Conditions | | Limits for Indicated Temp.(^O C) | | | | | | |
|---|---------------------------|-----------------------|----------------------------|---|-----|---------|------|-----|-------|------------------|
| | Sym- bol | v+ | = +6 V, | Minimum | | Maximum | | | Units | |
| | | V [.] = -6 V | | -55 | +25 | +125 | - 55 | +25 | +125 | |
| STATIC | | | | | | | | | | |
| Input Offset Voltage | v ₁₀ | - | | - | - | - | 6.5 | 5 | 6.5 | m∨ |
| Input Offset Current | 110 | - | | - | - | - | 20 | 10 | 20 | μA |
| Input Bias Current | կ | _ | | - | - | - | 70 | 36 | 25 | μA |
| Quiescent Operating | V ₈ or | Terminal 4 | Terminal 5 | | | | | | | |
| Voltage | v ₁₀ | NC | NC | _ ' | 1.5 | _ | - | 3.2 | - | v |
| | | Terminal 4 | Terminal 5 | | | | | | | |
| | | NC | NC | 30 | 25 | 20 | 60 | 60 | 50 | m₩ |
| Device Dissipation | Рт | NC | - VEE | 25 | 20 | 15 | 55 | 55 | 50 | mW |
| | | · V _{EE} | NC | 55 | 50 | 45 | 105 | 105 | 90 | m₩ |
| | | ۰۷ _{EE} | -V _{EE} | 35 | 35 | 25 | 70 | 70 | 65 | m₩ |
| DYNAMIC | | | | | | | | | | |
| Differential Voltage Gain | A _{Diff} | | Single- Ended Output | - | 28 | - | - | - | - | dB |
| Maximum Output Voltage | V _{ОUТ} (р-р) | | | - | 5 | - | - | - | - | ٧ _{p-F} |
| Bandwidth at -3 dB Point | BW | | | - | 600 | - | - | - | - | kHz |
| Common-Mode Rejection Ratio | CMR | | | - | 70 | - | - | - | | dB |
| AGC Range (Maximum Volt- age Gain to Complete Cut- off) | AGC | | <u></u> , | - | 80 | - | - | - | - | dB |

TABLE A. POST BURN-IN, FINAL ELECTRICAL AND GROUP A SAMPLING TESTS

CA3000/...



Burn-in and operating life test circuit



Schematic Diagram

| TABLE B. DELTA LIMITS at $T_A = 2$ | $25^{\circ}C, V^{\dagger} = +6V,$ | $V^{-} = -6 V (/1 \text{ only})$ |
|------------------------------------|-----------------------------------|----------------------------------|
|------------------------------------|-----------------------------------|----------------------------------|

| CHARACTERISTIC | SYMBOL | TEST CONDITIONS | LIMITS MAX. A | UNITS | |
|--------------------------------|--------------|----------------------------------|------------------|-------|--|
| Input Bias Current | 4 | - | ±4 | | |
| Quiescent Operating Voltage | Vg or V10 | Terminal 4: NC Terminal 5: NC | ±0.3 | v | |
| Device Dissipation | Рт | Terminal 4: NC Terminal 5: NC | ±6 | m₩ | |
| Input Offset Current | ١o | _ | ±2 | μA | |
| Input Offset Voltage | VIO | _ | ±1 | mV | |

TABLE C. GROUPS C AND D END-POINT TESTS at $T_A = 25^{\circ}C$

| | | TEST CONDITIONS | Lin | Units | |
|---|-----------|--|------|-------|----|
| Characteristic | Symbol | v ⁺ = +6 v, v ⁻ = -6 v | Min. | Max. | |
| Input Offset Voltage | VIO | | _ | 5 | mV |
| Input Offset Current | 10 | | - | 10 | μΑ |
| Input Bias Current | 4 | | - | 36 | μA |
| Quiescent Operating Voltage | V8 or V10 | | 1.5 | 3.2 | V |
| Device Dissipation | PT | Terminal 4 NC Terminal 5 NC | 25 | 60 | mW |
| Differential Voltage Gain Single-Ended Input | ADIFF | Single Ended Output f = 1 kHz | 28 | - | dB |